## E lectron interaction with dom ain walls in antiferrom agnetically coupled multilayers

F.G.Aliev<sup>1;</sup>, R.Schad<sup>2</sup>, A.Volodin<sup>3</sup>, K.Tem st<sup>3</sup>, C.Van Haesendonck<sup>3</sup>,

Y. Bruynseraede<sup>3</sup>, I. Vavra<sup>4</sup>; V. K. Dugaev<sup>5;6</sup>, and R. Villar<sup>1</sup>

<sup>1</sup>D pto. Fisica Materia Condensada, C-III, Universidad Autonom a de Madrid, Spain

<sup>2</sup>CMIT, University of Alabama, Tuscaloosa, AL 35487, USA

<sup>3</sup>Laboratorium voor vaste Sto fysica en Magnetisme, K.U.Leuven, B-3001 Leuven, Belgium

<sup>4</sup> Institute of Electrical Engineering – SAS, 84239 Bratislava, Slovakia

 $^5\mathrm{M}$  ax-P lanck-Institut fur M ikrostrukturphysik, W einberg 2, 06120 Halle, Germ any and

<sup>6</sup> Institute for P roblem s of M aterials Science, N ational A cadem y of Sciences of U kraine, 58001 C hemovtsy, U kraine

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For antiferrom agnetically coupled Fe/Crmultilayers the low eld contribution to the resistivity  $_{D W}$ , which is caused by the domain walls, is strongly enhanced at low temperatures. The low temperature resistivity  $_{D W}$  varies according to a power law  $_{D W}$  (T) =  $_{D W}$  (0) A T with the exponent ' 0:7 1: This behavior can not be explained assuming ballistic electron transport through the domain walls. It is necessary to invoke the suppression of anti-localization e ects (positive quantum correction to conductivity) by the nonuniform gauge elds caused by the domain walls.

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Renewed interest in the domain wall (DW) contribution to the resistivity is stimulated by its relevance for fundam ental physics [1, 2, 3, 4, 5] and possible applications. Indeed, dom ain walls may strongly in uence the electrical noise and operation of magnetoelectronics devices [6]. Although the number of DW s was controlled and directly observed in Fe [5] and in Co  $\ln s$  [3] at room tem perature, where DW form ation is relatively well understood, no clear picture has emerged allowing to explain the results. The anisotropic magnetoresistance (AMR) dominates the low eld magnetoresistance and complicates the extraction of the true DW contribution to the resistivity [7]. In order to minimize the AMR contribution, thin Im swith reduced magnetization and special DW con guration have been studied [8]. A part from the ballistic contribution to the DW magnetoresistance [9], quantum interference also a ects the electron transport through DW s [10, 11].

A ntiferrom agnetically (AF) coupled m agnetic multilayers (M M Ls) are system s with reduced m agnetization and consequently a strongly suppressed AM R.At high tem peratures, weak pinning of the DW s in the M M Ls is expected to suppress the DW m agnetoresistance. For xed m agnetic eld the DW m agnetoresistance should em erge at su ciently low tem peratures where DW s becom e strongly pinned and their con guration is not affected by therm al uctuations or by the applied electrical current.

Here, we report on our detailed study of the low eld electrical resistivity in AF coupled Fe/CrMMLs. The well known giant magnetoresistance (GMR) in this system is dom inated by a realignment of the magnetization direction in adjacent magnetic layers [12]. The presence of DW s should result in an additional, small in-plane magnetoresistance [13]. While the GMR is known to saturate at low temperatures [14], the temperature dependence of DW m agnetoresistance is still a m atter of controversy. In order to separate the two contributions, we perform ed a system atic study of the tem perature dependence of the resistivity in low m agnetic elds. Our m ain ndings are that (i) the presence of DW s in an AF coupled MML does not a ect the resistivity at room tem perature, and (ii) at low tem peratures the DW contribution to the resistivity becom espositive and strongly tem perature dependent. We explain these observations in terms of the suppression of positive quantum correction to conductivity (so called "anti-localization" e ect) by the dom ain walls.

Epitaxial  $[Fe/Cr]_{10}$  multilayers with 10 bilayers are prepared in a molecular beam epitaxy system on M gO (100) oriented substrates held at 50 C and covered with an approximately 10A thick Cr layer. The thickness of the Fe layer was varied between 9 and 30A, while the Cr layer thickness (typically 12 to 13 A) corresponds to the

rst antiferrom agnetic peak in the interlayer exchange coupling for the Fe/Cr system [15] and produces a m axim um GMR which is about 20% at 300K and 100% at 42K. A commercial cryogenic system (PPMS, Quantum Design) was used to measure magnetization, magnetic susceptibility, and electrical resistance with a standard four-probe ac method at a frequency of 321 Hz with currents ranging between 15 and 50 A. The magnetic

elds created by these currents are wellbelow 0:10 e and do not a ect the DW s. The magnetic eld dependence of the susceptibility along di erent crystallographic directions as well as the low residual resistivity (typically less than 13 cm at a saturation eld of 1T) con m the good epitaxial growth of our M M Ls. M agnetization m easurem ents at 42K reveal that the antiferrom agnetic fraction (1  $M_r=M_s$ ), with  $M_r$  and  $M_s$  the rem anent and the saturation m agnetization, respectively, exceeds 80%. This indicates that bilinear AF coupling dom inates

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FIG.1: Room temperature and low temperature normalized magnetoresistance (H) = (1500 e) for an  $[Fe(12A)/Cr]_{10}$  multilayer with the current I parallel to the eld H and parallel to the (110) direction. The inset shows a typical MFM image (8 8 m<sup>2</sup>) of AF coupled  $Fe/Cr_{10}$  multilayer at 42K

over biquadratic exchange coupling [16]. The existence of as mallnon-compensated magnetic moment may allow DW motion in our articial antiferrom agnet.

The inset in Fig. 1a shows a typical magnetic image of an AF coupled Fe/Cr MML at T = 42K (image size is 8 8 m<sup>2</sup>) using a hom e-built cryogenic magnetic force m icroscope (MFM) [17]. The MFM picture, which "feels" magnetic contrast, reveals di erent irregularly shaped domain walls (which is a characteristic feature of strong AF coupling [12,18]) with m icrom eter dimensions. W hile our MFM measurements reveal a similar domain structure at room temperatures, the magnetoresistance curves, which are shown in Fig.1, are very di erent. The low eld magnetoresistance is strongly enhanced at low temperatures. The susceptibility data point towards a weak pinning of the DW s at room temperature and a strong pinning at low temperatures [19].

Figure 2a shows the tem perature dependence of the electrical resistivity for an  $Fe(12A)/Cr_{h0}MML$  for di erent magnetic elds († Hj 3000e). The magnetic eld is applied in the plane of the lm and is parallel to the current as well as to the longer side of the rect- $25 \text{ m}^2$ ) sample which is directed along the angular (5 (110) axis. For  $\frac{1}{1}$  j> 1000 e the (T) dependence reveals a metallic behavior, while for  $\frac{1}{1}$  j 1000 e there appears a shallow minimum in the (T) curves. We note that in the (T) curves measured after crossing zero eld there appear aperiodic peaks when the applied current is smaller than 20 A, which correspond to an intrinsic noise process in the sample. The peaks, which can be linked to Barkhausen noise, gradually disappear when

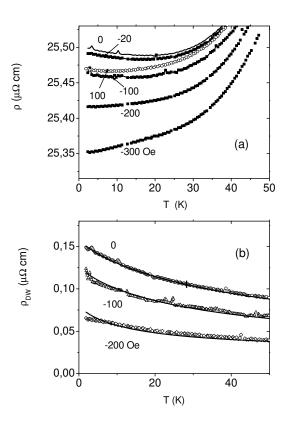


FIG. 2: (a) Temperature dependence of the resistivity for  $[Fe(12A)/Cr]_{10}$  multilayer in di erent magnetic elds. Both the eld and the current are along the (110) axis. (b) Temperature dependence of the DW contribution to the resistivity.  $D_W = (T; H)$  ( $T; H_S$ ) determined from the data shown in (a) for  $H_S = 3000 e$ . The solid lines correspond to the ts which are described in the text.

doubling the electrical current or when the absolute value of the magnetic eld exceeds 3000 e [20].

A straightforward way to determ ine the magnetoresistivity of the DW s is to subtract the tem perature dependences of the resistivity measured in the presence and in the absence of DW s, respectively. However, the magnetic eld  $H_{c}^{0}$  which quarantees nearly uniform N eel vector along the external eld (according to our magnetic susceptibility data  $3000 e < H_S^0 < 10000 e$ ), not only sweeps the DW s out of the sample, but may also change the angle of the magnetization between adjacent m agnetic layers from the antiparallel alignm ent (GMR). In order to separate the magnetoresistivity induced by the GMR e ect from the magnetoresistivity induced by the DW s, we de ne  $_{DW} = (T; H)$ (T;H<sub>S</sub>) with ĴHsj 3000e. Although this method may underestim ate the magnetoresistivity of the DW s because not all domains will be removed by the applied eld  $H_S$ , the m ethod provides a possibility to determ ine the tem perature dependence of the DW m agnetoresistivity. In Fig.2b we show DW (T;H) between 1.9 and 100K for di erent

m agnetic elds ranging between 2000e and zero eld for H<sub>S</sub> = 3000e. We nd that, in contrast to the GMR, the DW m agnetoresistivity is strongly temperature dependent with no sign of saturation at low temperatures.

A ssum ing that the magnetic eld mainly changes the e ective DW concentration  $n_{DW}$  [21], we expect DWto scale according to  $_{DW} = _{DW} (0)$ <sub>DW</sub> (T) /  $n_{D W}$  (H)  $^{0}_{D W}$  (T) with  $^{0}_{D W}$  (T) a function describing the tem perature dependent electron interaction with DW s. Determ ined in this way  $^0_{DW}$  (T) which is independent of the choice of H<sub>s</sub> as long as  $\frac{1}{H_s}$  j 3000e. Our data analysis reveals that the DW resistivity is roughly f<sup>:7</sup> (Fig. 3a) illustrates n<sub>DW</sub> (H) given by DW  $_{DW}$  / T<sup>0:7</sup> for di erent magnetic elds the scaling ∄j< H<sub>S</sub> = 3000 e for tem peratures between 1:9K and 25 K. For comparison we also show the qualitatively di erent tem perature scaling for the GMR (see dashed line in Fig. 3a). The vertical bar in Fig. 2b estimates the maximum in uence of the GMR e ect on our data. This estimation was obtained from the temperature dependence of the magnetoresistivity measured for two di erent magnetic elds su ciently large to remove all DW s. In agreem ent with previous results [14, 22], both saturation eld and GMR are weakly tem perature dependent below 50K, GMR saturates as T<sup>2</sup> and changes in less than 7% .

Next, we demonstrate that neither the AMR, which depends on the relative orientation of the m agnetization and the current I, nor the ordinary magnetoresistivity (caused by the Lorentz force), which depends on the relative orientation of I and the magnetic induction B, contribute to DW. The upper curves in Fig. 3b correspond  $_{DW}$  (H  $_{S}$  = 2000 e for the current parallel to (line) to or perpendicular to (circles) the magnetic eld H applied parallel to the (110) direction (see inset in Fig. 3a). If the AMR a ects the low eld magnetoresistivity, its contribution will be positive when the eld is parallel to the current and negative when the eld is perpendicular to the current [1]. It is, how ever, clear that DW is alm ost identical for both cases, indicating the AMR e ects can be neglected. The magnetic eld dependence of the DW resistivity is reduced when the eld is applied along the (100) axis (see low er curve in Fig. 3b). This probably re-

ects the presence of a crystal lattice induced an isotropy in the potential barrier which pins the DW s. We have obtained sim ilar results with a slightly di errent scaling of the low temperature DW m agnetoresistivity for three other AF coupled Fe/Cr sam ples with an Fe layer thickness of 9, 22 and 30 A, respectively. The inset in Fig. 3b shows the dependence of the scaling exponent on the Fe thickness. This may re ect a change of the exponent p in the temperature dependence of the phase breaking time  $\cdot$  / T <sup>p=2</sup> which should occur between the "dirty" (p = 3=2) and "clean" (p = 2) lim its [23].

A ballistic approach for the electron transport through

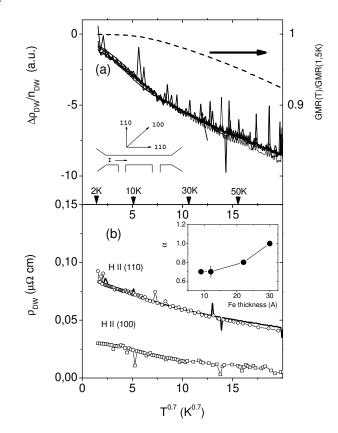


FIG.3: (a) Normalized temperature dependence of the DW contribution to the resistivity. The data have been obtained for magnetic elds: +100;+20;0; 20; 100 and 2000e.  $n_{\text{D}\ \text{W}}$  (H ) is the concentration of dom ain walls, and the DW resistivity has been determined for  $H_s = 3000e$ . The dashed line corresponds to the GMR contribution which is obtained from the D W (T) dependence for H = 5000 ew ith Н<sub>S</sub> = 10000e. The inset gives a schematic view of the sam ple geom etry. (b) Tem perature dependence of the DW contribution to the resistivity for an  $Fe(12A)/Cr_{10}$  multilayer when H = 0 and for  $H_s = 2000$  e directed along the (110) direction. The circles correspond to the case where the eld H is perpendicular to the current I, while the solid line corresponds to the case where H is parallel to I. The open squares give  $D_W$  for H = 0, but with  $H_S = 2000$  e directed along the (100). The inset illustrates the dependence of the scaling exponent on the Fe layer thickness.

DW s [9] requires that the mean free path ' in our epitaxial layers exceeds the DW width D with 20 < D < 200 nm for Fe/C r/Fe trilayers [24]. Therefore, the condition for ballistic transport may only be fullled at su ciently low temperatures [25]. A lthough non-ballistic effects have not yet been incorporated into the theory [9], we believe that they cannot account for the strong variation of  $_{DW}$  down to 1:9K, because the mean free path is expected to saturate at low temperatures. Moreover, the strong pinning of DW s at low temperatures [19] in plies that a distortion of the current lines by dom ain walls [1] or a change of the DW con guration cannot account for the strongly tem perature dependent low eld contribution to the magnetoresistivity in antiferrom agnetically coupled m agnetic multilayers.

In order to explain the strong variation of the DW m agnetoresistivity at low temperatures, one has to go beyond the classical approach [9]. A possibility is to link the observed phenom ena either to standard, disorder related, weak localization e ects or to scattering by isolated spins. Our experimental results are in conict with both scenarios since the resistivity correction with and without magnetic eld is dierent when applying the magnetic eld along the hard or along the easy axis (see Fig. 3b). Moreover, we observe that (T; H) is dierent when the magnetic eld is changed at low temperature (4.2 K) or at high temperature (T > 150 K). Finally, we observe som e asymmetry in the (T; H) data taken for

elds with the same am plitude but applied along dierent directions (see data for H = 1000 e and H = 1000 e in Fig.2a).

Both [10] and [11] predict a destruction of weak electron localization by the domain walls, although the details of the destruction mechanism are dierent. Direct application of these models results in a sign of the DW magnetoresistivity which is opposite to the sign of the experimentally observed magnetoresistance. However, the sign of the localization correction may be reversed due to strong spin-orbit (SO) scattering (anti-localization) [26]. The suppression of the weak localization corrections by a DW, predicted in [10, 11], is related to the electrom agnetic vector potential, which can be linked to an external magnetic eld, the gauge

eld depends on the spin, giving rise to a di erent in uence of the domain wall on the di erent components of the so-called C opperon [11]. O ur measurements are consistent with an anti-localization e ect in the absence of DW s (H > 3000 e) which is suppressed in the presence of DW s (H = 0). The appearance of anti-localization is due to the SO scattering which suppresses the triplet C opperons and does not a ect the singlet C opperon [23].

The SO interaction should be more pronounced in the case of multilayered structures than in single lm s. The potential steps at the interfaces in combination with the relativistic terms in the H am iltonian m ay produce strong SO scattering. The corresponding theory for the interface SO interaction has been proposed by Bychkov and R ashba [27]. In the case of Fe/Cr multilayers the potential steps are about 2.5 eV for the majority electrons, and one can expect a signi cant SO scattering from the interface. In case of strong SO scattering the magnetoresistance is caused by the destruction of the singlet C coperon by the gauge eld of the DW s. The model [10] predicts a suppression of all components of the C coperon, while the approach of Lyanda-G eller et al. [11] relies on

the suppression of som e of the com ponents.

When 'D, we can characterize the system in terms of a local conductivity, which is dened as an average over distances larger than 'but smaller than D. For the local conductivity inside a DW we can estimate the localization correction that is determined by smaller di usive trajectories with size L < D as well as by large trajectories D < L < L. L, is the phase relaxation length governing the destruction of the interference e ects. The localization corrections associated with the small trajectories are suppressed by the gauge eld since they are located within the DW. The contribution of large trajectories to localization is small, and for strong spin-orbit scattering the local conductivity within a DW is

where  $L_{D W}$  is the characteristic length which is determined by the in unnee of the gauge potential A. Its magnitude can be estimated as A 1=D, and consequently  $L_{D W}$  D.

Since the anti-localization correction without DW is

,

$$_{0} + \frac{e^{2}}{4^{2}h} \frac{1}{2} \frac{1}{L}, \qquad (2)$$

we are able to estim ate the di erence in m agnetoresistivity due to the DW s as

$$_{DW}$$
 '  $\frac{e^2}{4^2 h}$   $\frac{1}{L_{DW}^2} + \frac{1}{L_r^2}$   $\frac{1}{L_r}$  (3)

by taking into account that  $_{DW}$  '  $_{DW}$  <sup>2</sup>: The most important feature of our evaluation of the antilocalization e ects is the fact that the correction to the local conductivity is determined by the gauge eld inside the DW. If the current ow crosses the DW s, the corrections to the local conductivity, calculated for a narrow region inside a DW, show up in the sample resistance.

We can also estimate the in unnece of an external magnetic eld of 3000 e and of the internal magnetization on the localization corrections. These e ects are small when the magnetic length  $l_{\rm H}$   $h_{\rm C}=(\rm eH$ ) '. For H = 3000 e,  $l_{\rm H}$  ' 1:4 10<sup>5</sup> cm . A sum ing the internal magnetic induction B = 2T (typical value for Fe), we obtain the corresponding length  $l_{\rm H}$  ' 1:8 10<sup>6</sup> cm . On the other hand, the mean free path '' 10<sup>7</sup> cm . Thus, both the external magnetic eld and the magnetization are unable to e ectively suppress the anti-localization corrections.

We are able to t our data to Eq. (3) when we assume that  $L_{DW}$  is independent of tem perature and that the phase breaking length L, varies with tem perature according to a power law L, / T  $^{p=2}$  [23]. On the other hand, we have to introduce an additional (constant) shift of the data which takes into account the change of the

resistance due to the variation of the angle between m agnetic layers. It is important to note that the three different ts presented in Fig. 2b correspond to the same

tting param eters (w ith p = 3=2), except for the param - eter which describes the magnetic contrast ( $L_{D,W}$ ). We

nd that the e ective DW width  $I_{\!\!\mathcal{D}\ W}$  becomes about 2.5 times larger when the magnetic eld is increased from 0 to 2000 e.

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[\*] Corresponding author. E-m ail: farkhad aliev@ uam .es

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